## Notice of References Cited

Application/Control No. 09/735,887

Applicant(s)/Patent Under Reexamination WATANABE ET AL.

Examiner

John L Shew

Art Unit 2664

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,587,985 B1	07-2003	Fukushima et al.	714/748
	В	US-5,903,673 A	05-1999	Wang et al.	382/236
	С	US-6,637,031 B1	10-2003	Chou, Philip A.	725/87
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q				:	
	R					
	S					
	Т			_		

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

